

<i>Notice of References Cited</i>	Application/Control No. 10/521,057		Applicant(s)/Patent Under Reexamination YOUN ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0044657	03-2004	Lee, Jae-Hak	707/003
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FOREIGN PATENT DOCUMENTS

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